

# MOSFET

Metal Oxide Semiconductor Field Effect Transistor

## CFDA Automotive

650V CoolMOS™ CFDA Power Transistor  
IPx65R110CFDA

## Data Sheet

Rev. 2.0  
Final

## 1 Description

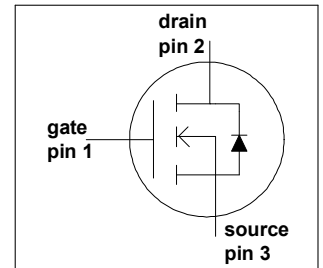
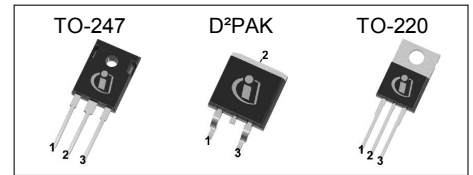
CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. 650V CoolMOS™ CFDA series combines the experience of the leading SJ MOSFET supplier with high class innovation. The resulting devices provide all benefits of a fast switching SJ MOSFET while offering an extremely fast and robust body diode. This combination of extremely low switching, commutation and conduction losses together with highest robustness make especially resonant switching applications more reliable, more efficient, lighter, and cooler.

### Features

- Ultra-fast body diode
- Very high commutation ruggedness
- Extremely low losses due to very low FOM  $R_{ds(on)} \cdot Q_g$  and  $E_{oss}$
- Easy to use/drive
- Qualified according to AEC Q101
- Green package (RoHS compliant), Pb-free plating, halogen free for mold compound

### Applications

650V CoolMOS™ CFDA is designed for switching applications.



**Table 1 Key Performance Parameters**

Parameter	Value	Unit
$V_{DS}$	650	V
$R_{DS(on),max}$	0.11	$\Omega$
$Q_g,typ$	118	nC
$I_D,pulse$	99.6	A
$E_{oss @ 400V}$	9.2	$\mu J$
Body diode $di/dt$	900	A/ $\mu s$
$Q_{rr}$	0.8	$\mu C$
$t_{rr}$	150	ns
$I_{rrm}$	8.3	A

Type / Ordering Code	Package	Marking	Related Links
IPW65R110CFDA	PG-TO 247	65F6110A	-
IPB65R110CFDA	PG-TO 263		
IPP65R110CFDA	PG-TO 220		



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## 2 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$			31.2	A	$T_C = 25^\circ\text{C}$
				19.7		$T_C = 100^\circ\text{C}$
Pulsed drain current <sup>2)</sup>	$I_{D,pulse}$			99.6	A	$T_C = 25^\circ\text{C}$
Avalanche energy, single pulse	$E_{AS}$			845	mJ	$I_D = 6.2\text{A}$ , $V_{DD} = 50\text{V}$ (see table 19)
Avalanche energy, repetitive	$E_{AR}$			1.3	mJ	$I_D = 6.2\text{A}$ , $V_{DD} = 50\text{V}$
Avalanche current, repetitive	$I_{AR}$			6.2	A	
MOSFET dv/dt ruggedness	dv/dt			50	V/ns	$V_{DS} = 0 \dots 400\text{V}$
Gate source voltage	$V_{GS}$	-20		20	V	static
		-30		30		AC ( $f > 1\text{ Hz}$ )
Power dissipation (non FullPAK, SMD) TO-247, TO-220, D <sup>2</sup> PAK	$P_{Tot}$			277.8	W	$T_C = 25^\circ\text{C}$
Operating and storage temperature	$T_j, T_{stg}$	-40		150	°C	
Mounting torque (non FullPAK) TO-247, TO-220				60	Ncm	M3 and M3.5 screws
Continuous diode forward current	$I_S$			31.2	A	$T_C = 25^\circ\text{C}$
Diode pulse current	$I_{S,pulse}$			99.6	A	$T_C = 25^\circ\text{C}$
Reverse diode dv/dt <sup>3)</sup>	dv/dt			50	V/ns	$V_{DS} = 0 \dots 400\text{V}$ , $I_{SD} \leq I_D$ , $T_j = 25^\circ\text{C}$ (see table 17)
Maximum diode commutation speed	$di_f/dt$			900	A/ $\mu\text{s}$	

<sup>1)</sup> Limited by  $T_{j\text{ max}}$ .

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j\text{ max}}$

<sup>3)</sup> Identical low side and high side switch with identical  $R_G$

### 3 Thermal characteristics

**Table 3 Thermal characteristics TO-247, TO-220**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$			0.45	K/W	
Thermal resistance, junction - ambient	$R_{thJA}$			62	K/W	leaded
Soldering temperature, wavesoldering only allowed at leads	$T_{sold}$			260	°C	1.6 mm (0.063 in.) from case for 10s

**Table 4 Thermal characteristics D<sup>2</sup>PAK**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$			0.45	K/W	
Thermal resistance, junction - ambient <sup>1)</sup>	$R_{thJA}$			62	K/W	SMD version, device on PCB, minimal footprint
			35			SMD version, device on PCB, 6cm <sup>2</sup> cooling area
Soldering temperature, wave- & reflowsoldering allowed	$T_{sold}$			260	°C	reflow MSL

<sup>1)</sup> Device on 40mm\*40mm\*1.5mm one layer epoxy PCB FR4 with 6cm<sup>2</sup> copper area (thickness 70µm) for drain connection. PCB is vertical without air stream cooling.

## 4 Electrical characteristics

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 5 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage <sup>1)</sup>	$V_{(BR)DSS}$	650			V	$V_{GS} = 0V, I_D = 1mA$
Gate threshold voltage	$V_{GS(th)}$	3.5	4	4.5	V	$V_{DS} = V_{GS}, I_D = 1.3mA$
Zero gate voltage drain current	$I_{DSS}$			1.5	$\mu A$	$V_{DS} = 650V, V_{GS} = 0V, T_j = 25^\circ C$
			400			$V_{DS} = 650V, V_{GS} = 0V, T_j = 150^\circ C$
Gate-source leakage current	$I_{GSS}$			100	nA	$V_{GS} = 20V, V_{DS} = 0V$
Drain-source on-state resistance	$R_{DS(on)}$		0.099	0.11	$\Omega$	$V_{GS} = 10V, I_D = 12.7A, T_j = 25^\circ C$
			0.257			$V_{GS} = 10V, I_D = 12.7A, T_j = 150^\circ C$
Gate resistance	$R_G$		1.3		$\Omega$	$f = 1MHz, \text{open drain}$

**Table 6 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	$C_{iss}$		3240		pF	$V_{GS} = 0V, V_{DS} = 100V, f = 1MHz$
Output capacitance	$C_{oss}$		160		pF	
Effective output capacitance, energy related <sup>2)</sup>	$C_{o(er)}$		120		pF	$V_{GS} = 0V, V_{DS} = 0 \dots 400V$
Effective output capacitance, time related <sup>3)</sup>	$C_{o(tr)}$		553		pF	$I_D = \text{constant}, V_{GS} = 0V, V_{DS} = 0 \dots 400V$
Turn-on delay time	$t_{d(on)}$		16		ns	$V_{DD} = 480V, V_{GS} = 13V, I_D = 19.1A, R_G = 1.8\Omega$ (see table 18)
Rise time	$t_r$		11		ns	
Turn-off delay time	$t_{d(off)}$		68		ns	
Fall time	$t_f$		6		ns	

**Table 7 Gate charge characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{gs}$		21		nC	$V_{DD} = 480V, I_D = 19.1A, V_{GS} = 0 \text{ to } 10V$
Gate to drain charge	$Q_{gd}$		64		nC	
Gate charge total	$Q_g$		118		nC	
Gate plateau voltage	$V_{plateau}$		6.4		V	

<sup>1)</sup> For applications with applied blocking voltage > 65% of the specified blocking voltage, we recommend to evaluate the impact of the cosmic radiation effect in early design phase. For assessment please contact local Infineon sales office.

<sup>2)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V

<sup>3)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V

**Table 8 Reverse diode characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	$V_{SD}$		0.9		V	$V_{GS} = 0V, I_F = 19.1A, T_j = 25^\circ C$
Reverse recovery time	$t_{rr}$		150		ns	$V_R = 400V, I_F = 19.1A,$ $di_F/dt = 100A/\mu s$ (see table 17)
Reverse recovery charge	$Q_{rr}$		0.8		$\mu C$	
Peak reverse recovery current	$I_{rrm}$		8.3		A	

## 5 Electrical characteristics diagrams

Table 9

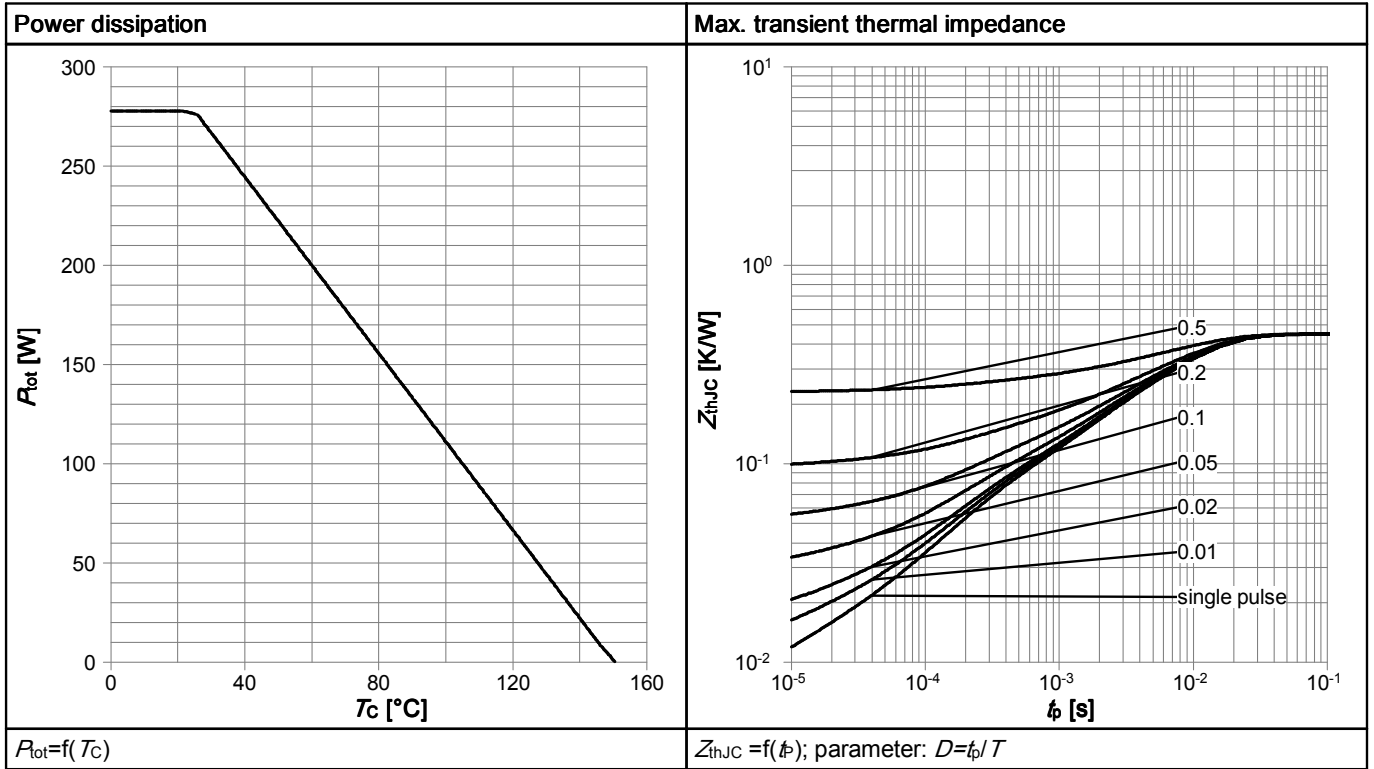


Table 10

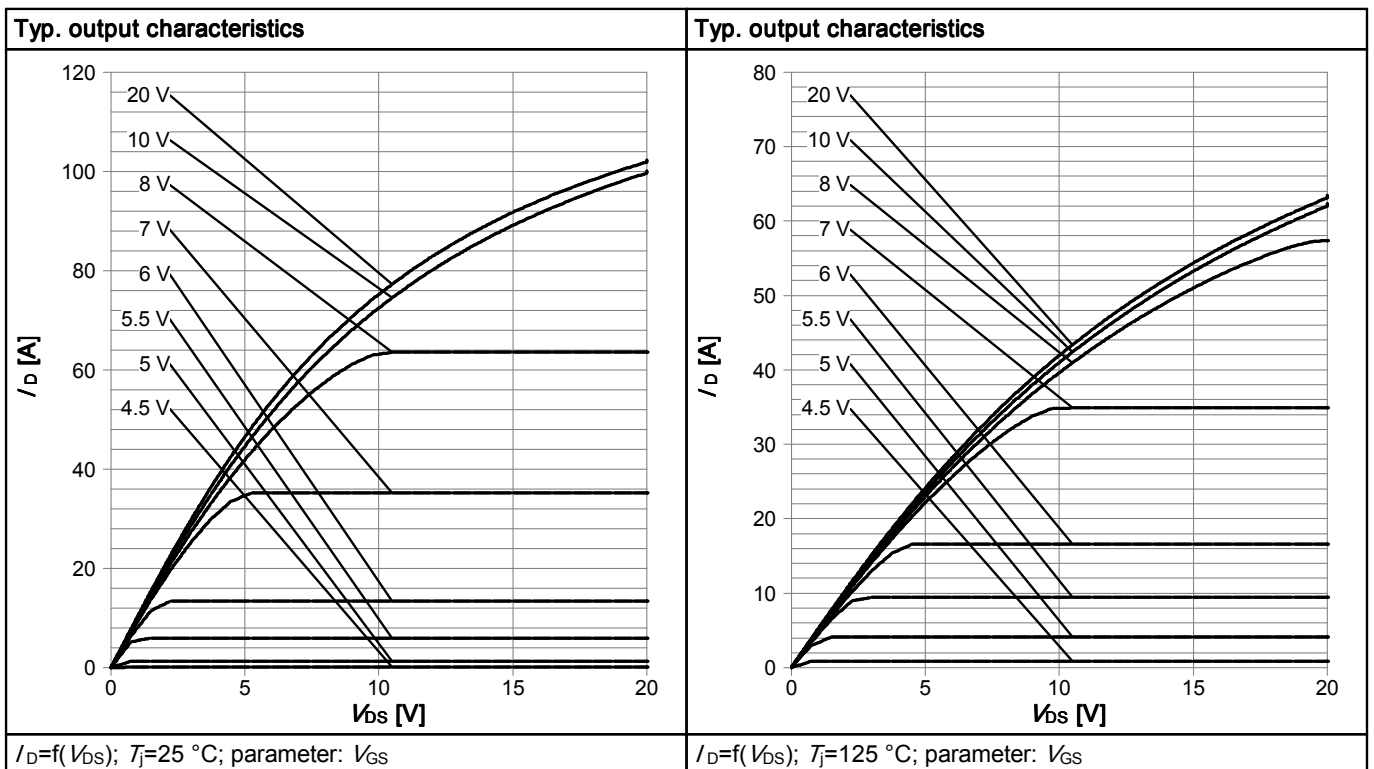




Table 11

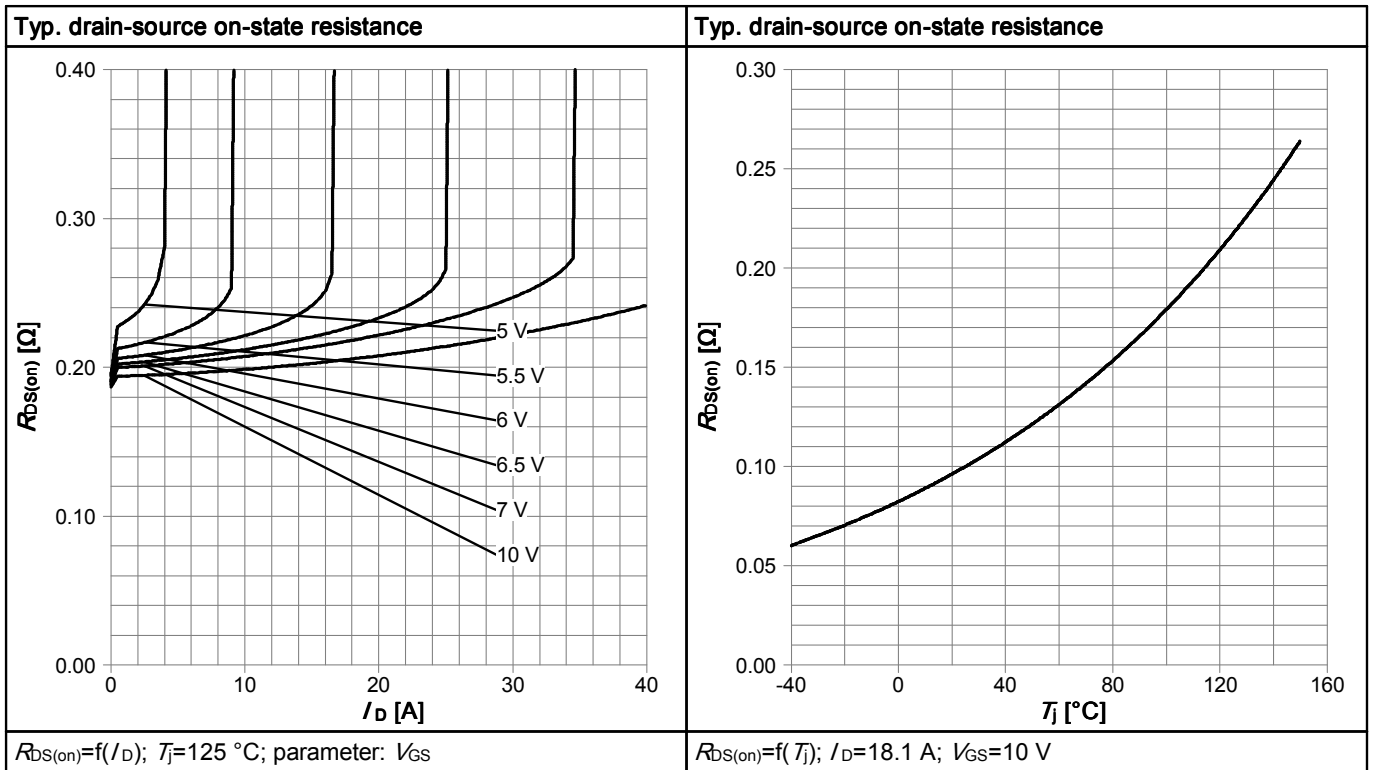


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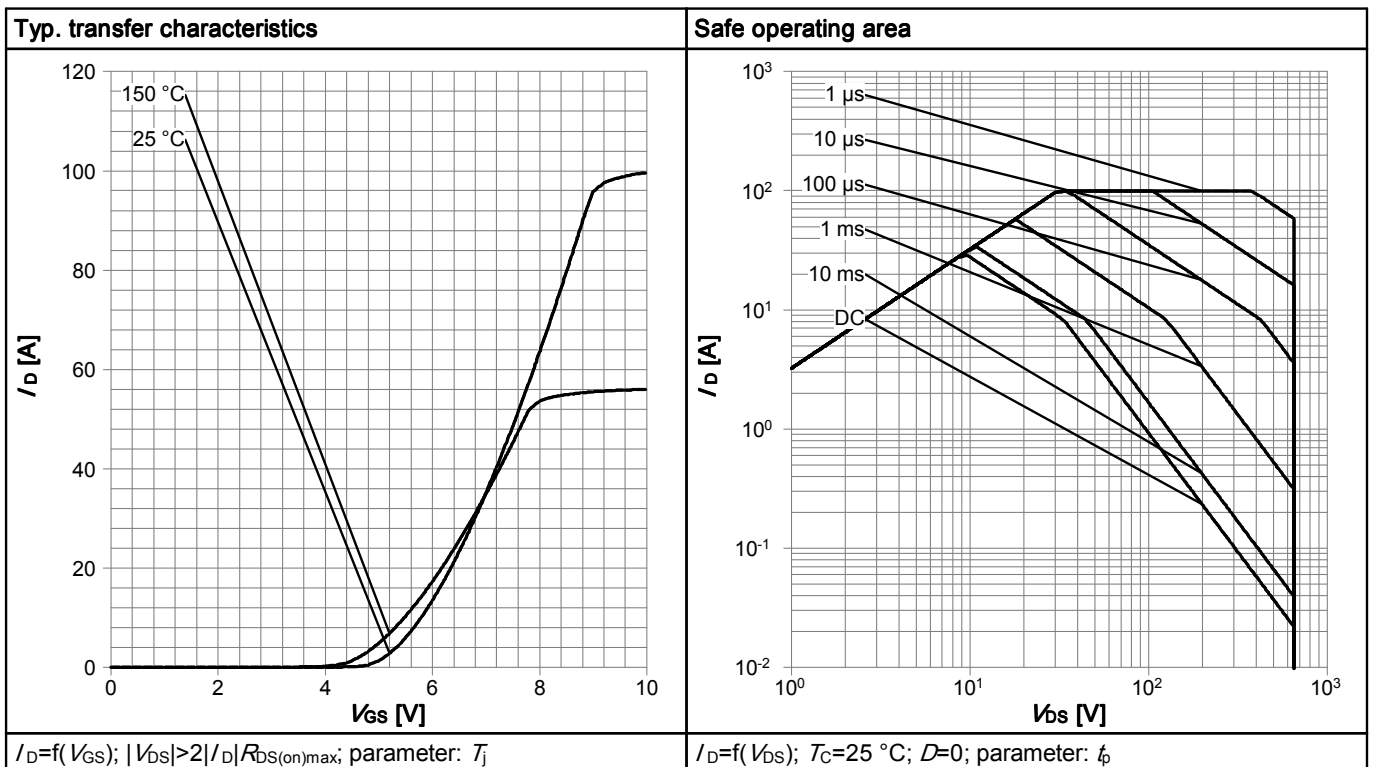


Table 13

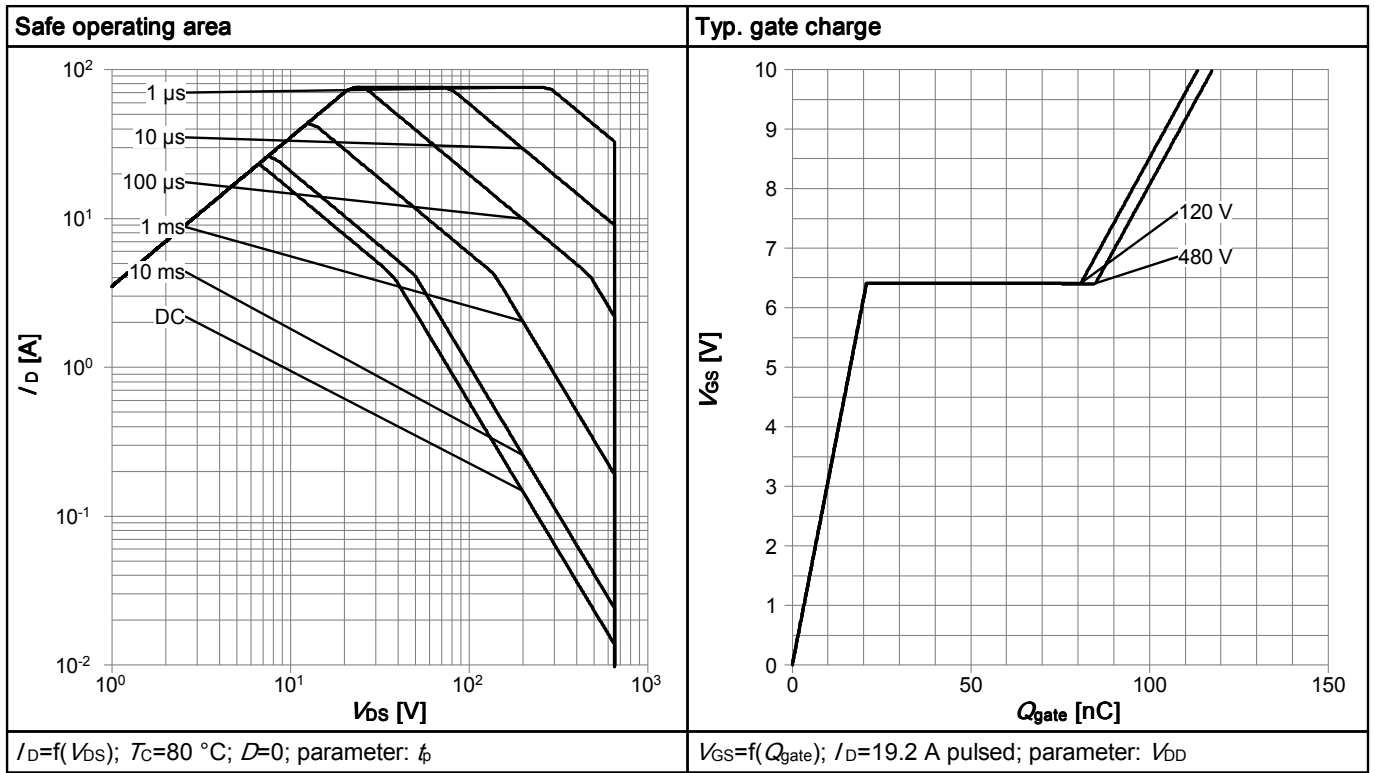
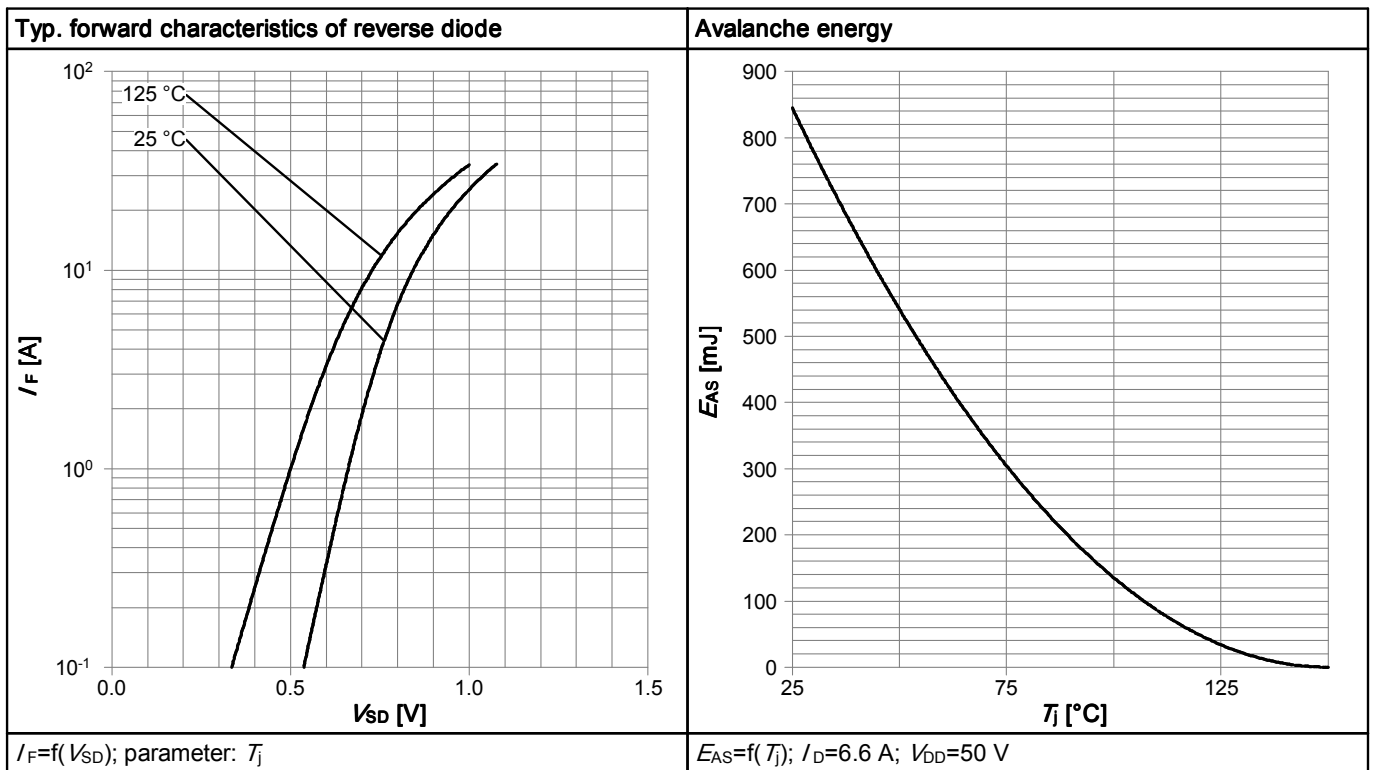
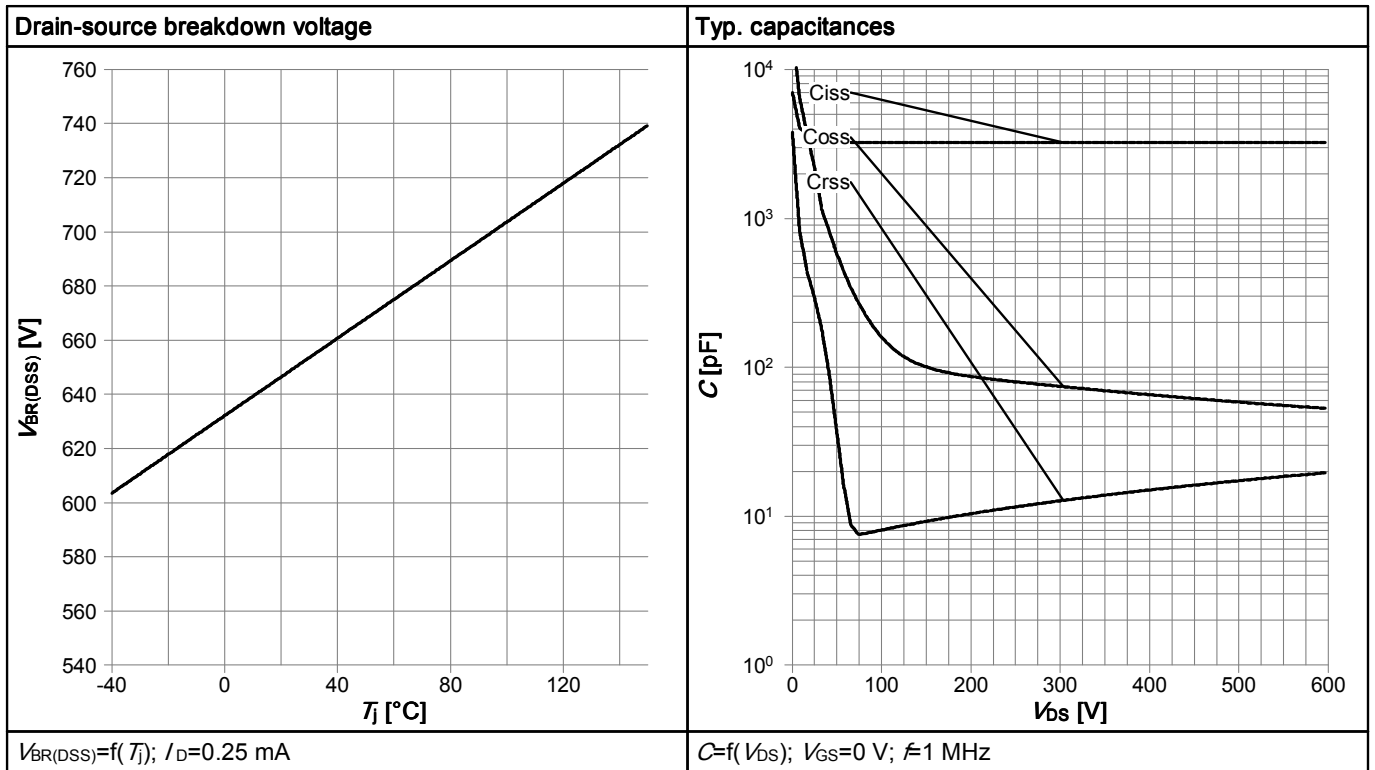


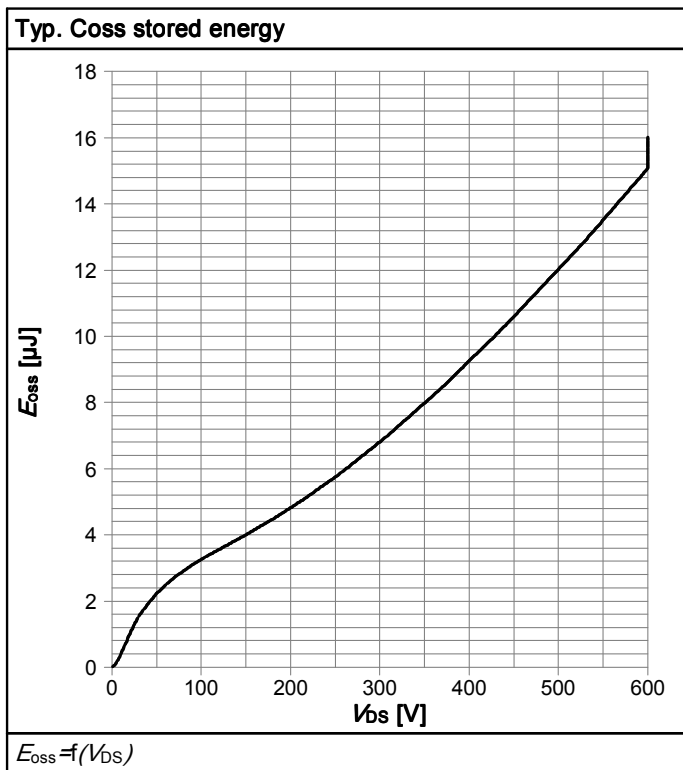
Table 14



**Table 15**

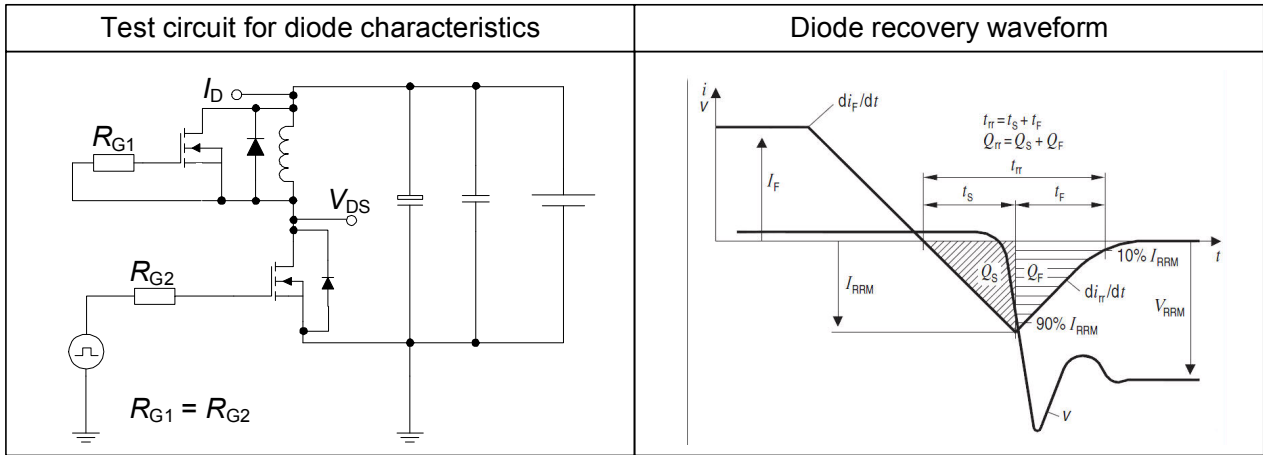


**Table 16**

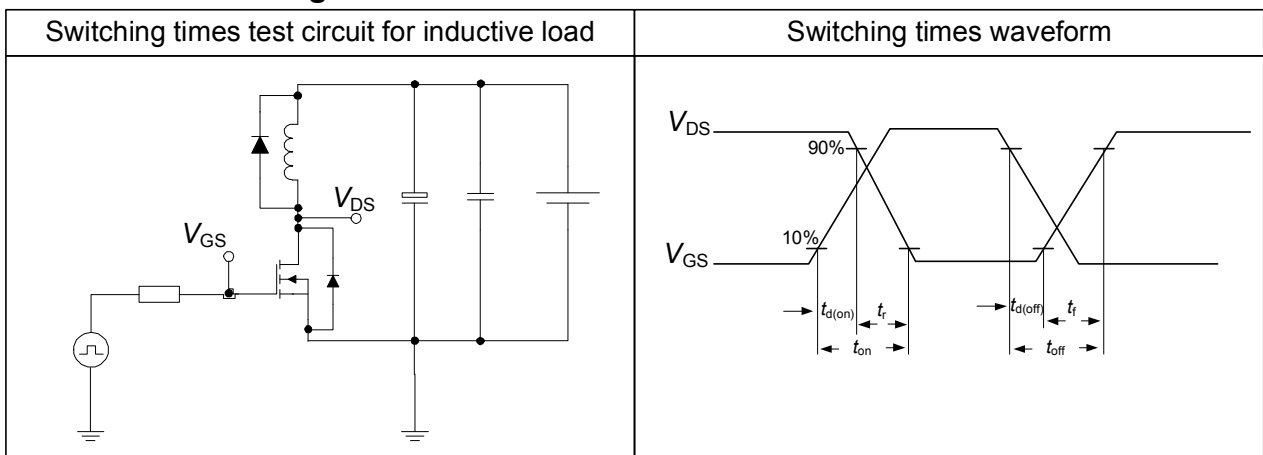


## 6 Test Circuits

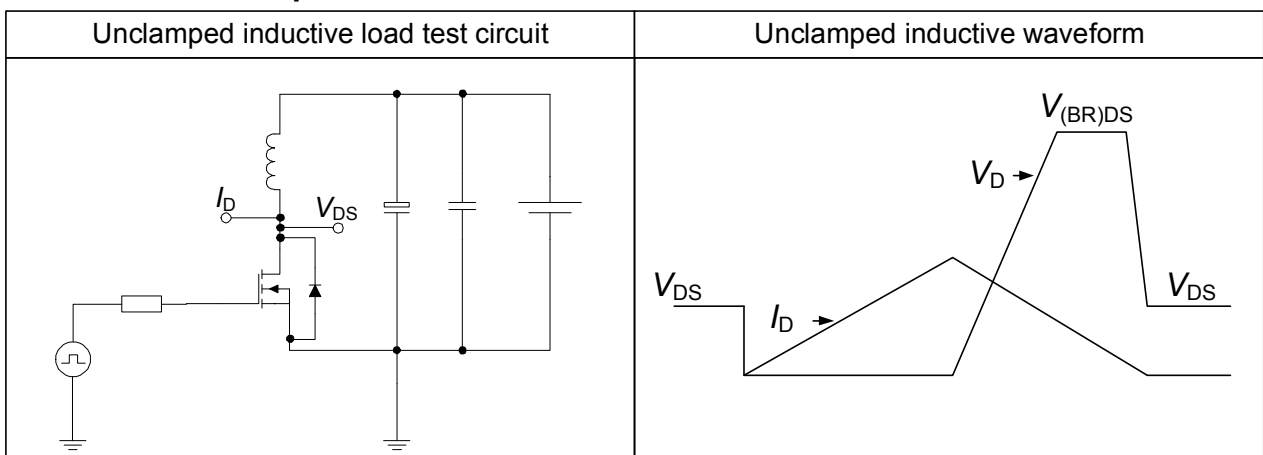
**Table 17 Diode characteristics**



**Table 18 Switching times**



**Table 19 Unclamped inductive**



## 7 Package Outlines

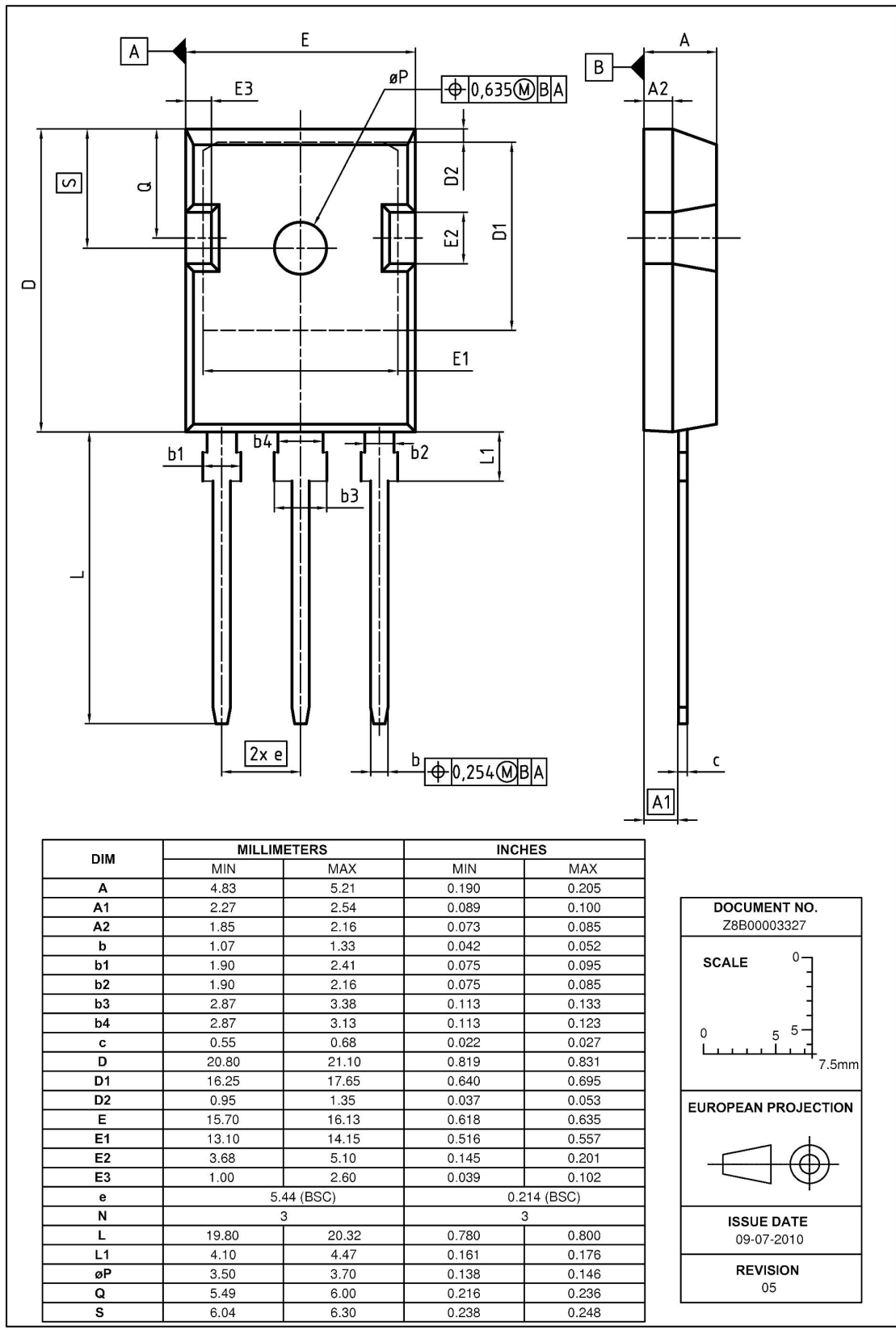


Figure 1 Outline PG-TO 247, dimensions in mm/inches

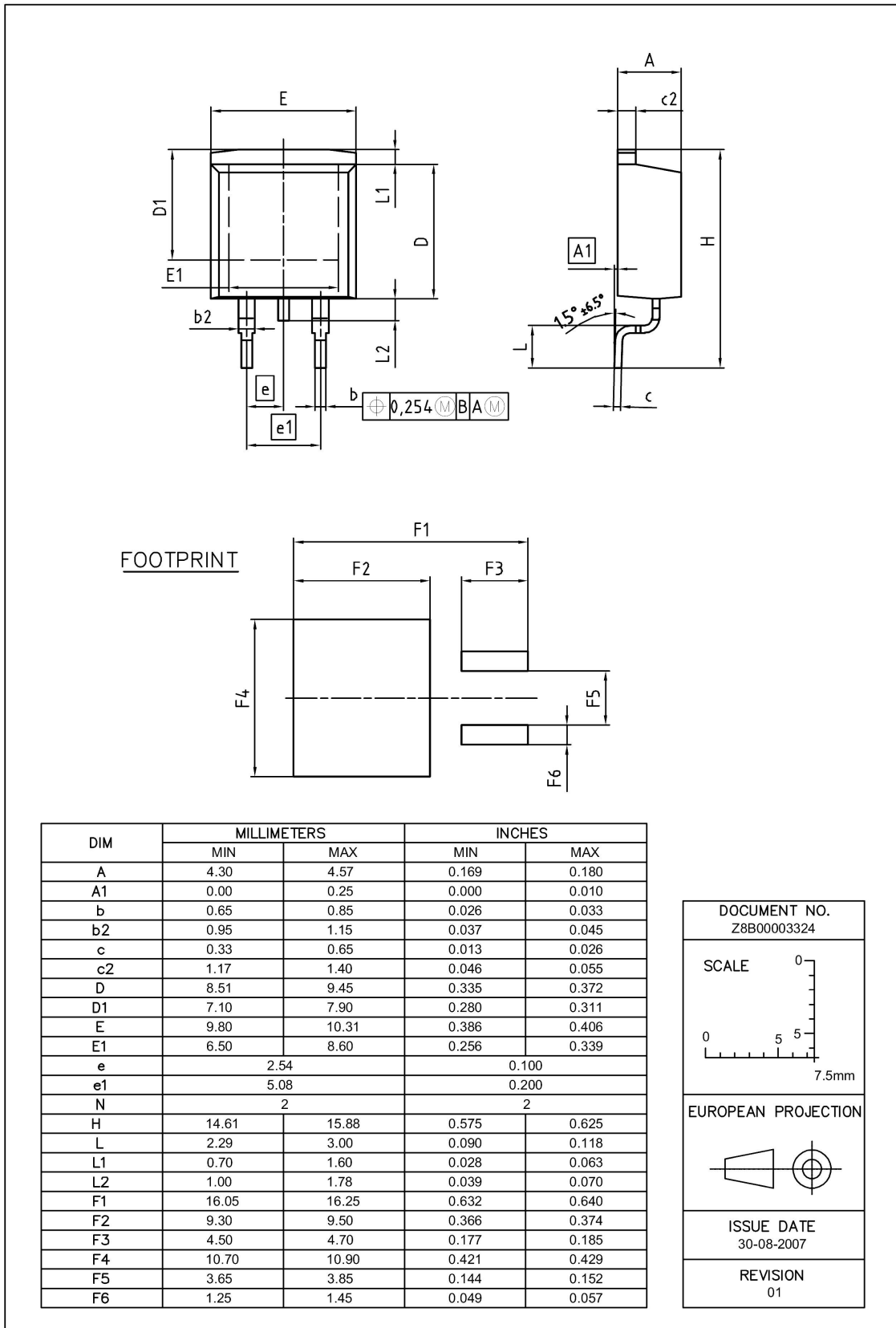


Figure 2 Outline PG-TO 263, dimensions in mm/inches

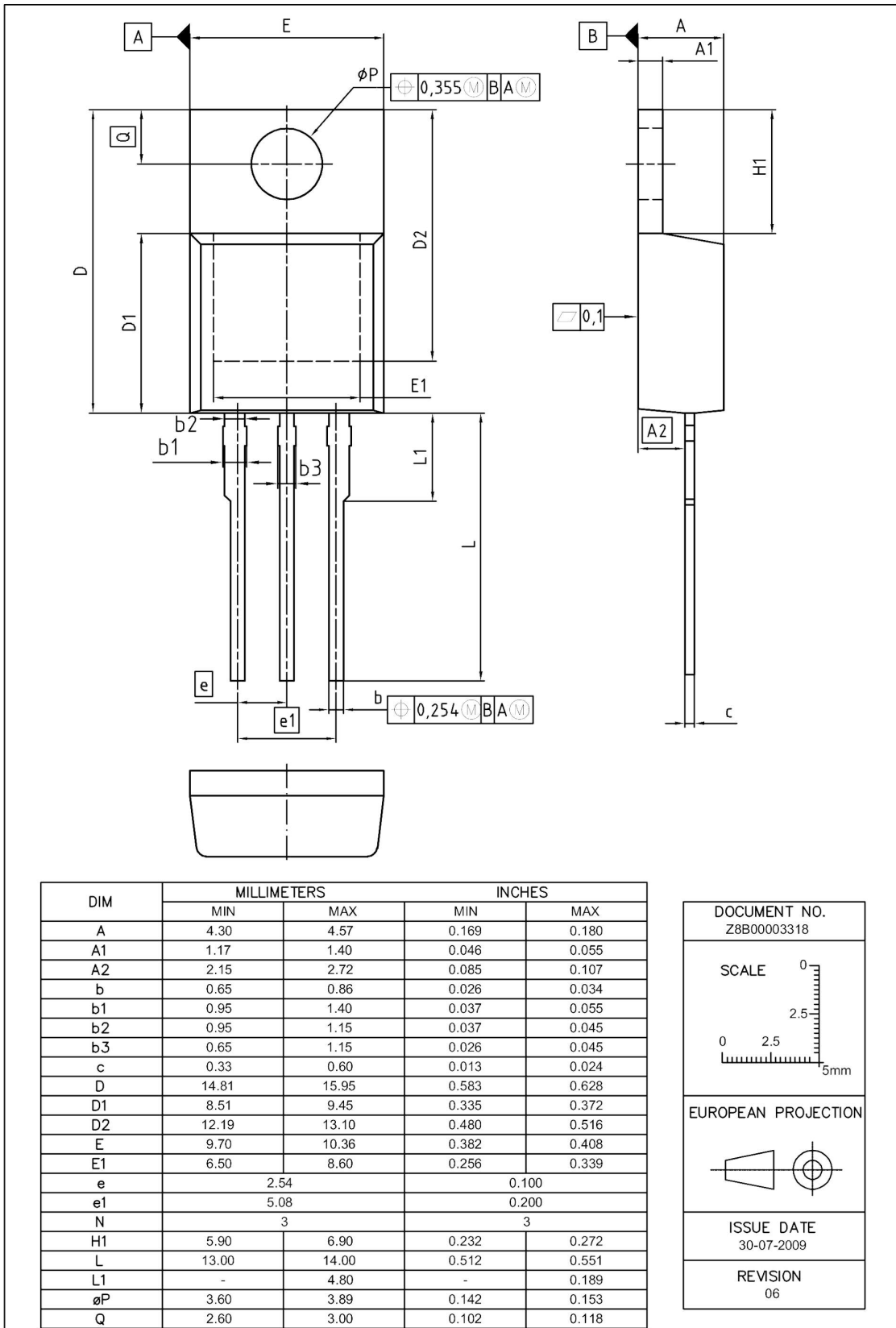


Figure 3 Outline PG-TO 220, dimensions in mm/inches

## Revision History

IPW65R110CFDA, IPB65R110CFDA, IPP65R110CFDA

**Revision: 2012-03-28, Rev. 2.0**

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2012-03-28	Final datasheet

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